

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination HUISENKA ET AL.	
		Examiner John A. Tweel, Jr.	Art Unit 2636	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,046,642	04-2000	Brayton et al.	330/296
	B	US-5,570,034	10-1996	Needham et al.	324/763
	C	US-5,392,293	02-1995	Hsue, Ching-Wen	324/765
	D	US-5,057,774	10-1991	Verhelst et al.	324/537
	E	US-5,025,344	06-1991	Maly et al.	361/88
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.